

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination FANG ET AL.	
		Examiner Helen Rossoshek	Art Unit 2825	Page 1 of 3

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Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination FANG ET AL.	
		Examiner Helen Rossoshek	Art Unit 2825	Page 2 of 3

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		Examiner Helen Rossoshek	Art Unit 2825	Page 3 of 3

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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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